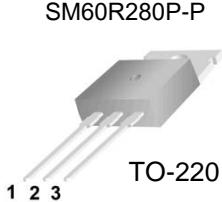
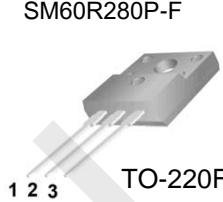
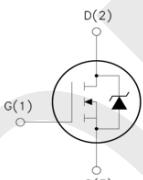


SM60R280P-P/SM60R280P-F Features: <ul style="list-style-type: none"> □ Low Intrinsic Capacitances. □ Excellent Switching Characteristics. □ Extended Safe Operating Area. □ Unrivalled Gate Charge :$Q_g = 43nC$ (Typ.). □ $V_{DSS} = 600V$, $I_D = 15A$ □ $R_{DS(on)} : 0.28\Omega$ (Max) @$V_G = 10V$ □ 100% Avalanche Tested 	    <p>1.Gate (G) 2.Drain (D) 3.Source (S)</p>
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Absolute Maximum Ratings ($T_C = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	SM60R280P-P	SM60R280P-S	Unit
V_{DSS}	Drain-Source Voltage	600		V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$) - Continuous ($T_C = 100^\circ C$)	15 9.4	15* 9.4*	A
I_{DM}	Drain Current - Pulsed (Note 1)	45	45*	A
V_{GSS}	Gate-Source voltage		± 30	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		284	mJ
I_{AR}	Avalanche Current (Note 1)		2.4	A
E_{AR}	Repetitive Avalanche Energy (Note 1)		0.43	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	104	32	W
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	$^\circ C$

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75.

Thermal Characteristics

Symbol	Parameter	SM60R280P-P	SM60R280P-S	Unit
R_{eJC}	Thermal Resistance, Junction-to-Case	1.2	3.9	$^\circ C/W$
R_{eCS}	Thermal Resistance, Case-to-Sink Typ.	0.5	-	$^\circ C/W$
R_{eJA}	Thermal Resistance, Junction-to-Ambient	62	80	$^\circ C/W$

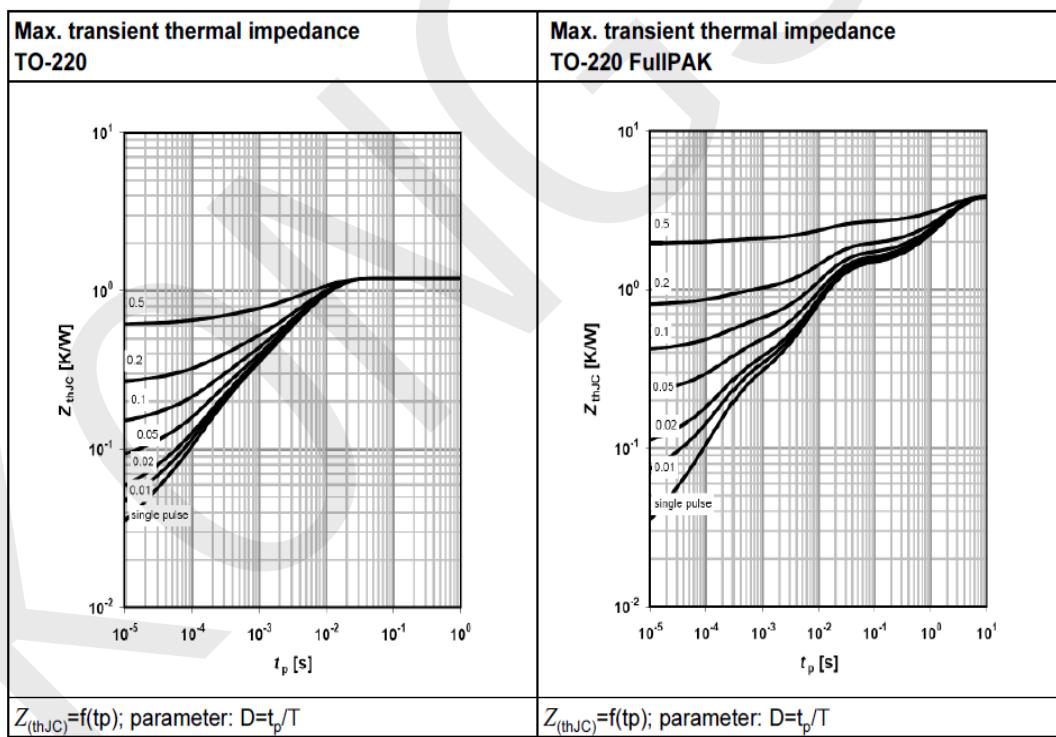
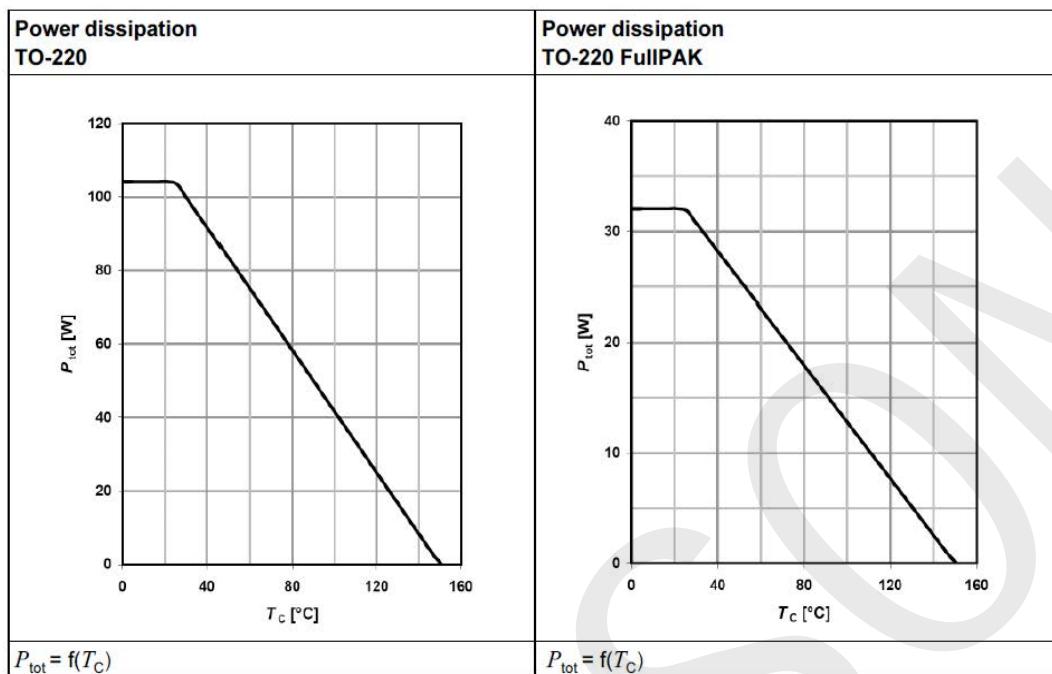
Electrical Characteristics (TC=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA, T _J = 25°C	600	-	-	V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C	-	650	-	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{Ds} = 600V, V _{GS} = 0V -T _J = 150°C	-	- 10	1	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{Ds} = 0V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{Ds} = 0V	-	-	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{Ds} = V _{GS} , I _D = 250μA	2.5	-	4.5	V
R _{D(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 7.5A	-	0.24	0.28	Ω
g _{FS}	Forward Transconductance	V _{Ds} = 40V, I _D = 15A	-	12	-	S
R _g	Gate resistance	f=1 MHz, open drain	-	3.5	-	Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{Ds} = 25V, V _{GS} = 0V, f = 1.0MHz	-	800	-	pF
C _{oss}	Output Capacitance		-	340	-	pF
C _{rss}	Reverse Transfer Capacitance		-	10	-	pF
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 400V, I _D = 7.5A, R _G = 20Ω (Note 4)	-	13	-	ns
t _r	Turn-On Rise Time		-	11	-	ns
t _{d(off)}	Turn-Off Delay Time		-	100	-	ns
t _f	Turn-Off Fall Time		-	12	-	ns
Q _g	Total Gate Charge	V _{Ds} = 480V, I _D = 7.5A, V _{GS} = 10V (Note 4)	-	43	-	nC
Q _{gs}	Gate-Source Charge		-	5	-	nC
Q _{gd}	Gate-Drain Charge		-	22	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current	-	-	15	A	
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	-	-	45	A	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 7.5A	-	0.9	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 7.5A, dI/dt = 100A/μs	-	345	-	ns
Q _{rr}	Reverse Recovery Charge		-	4.5	-	μC

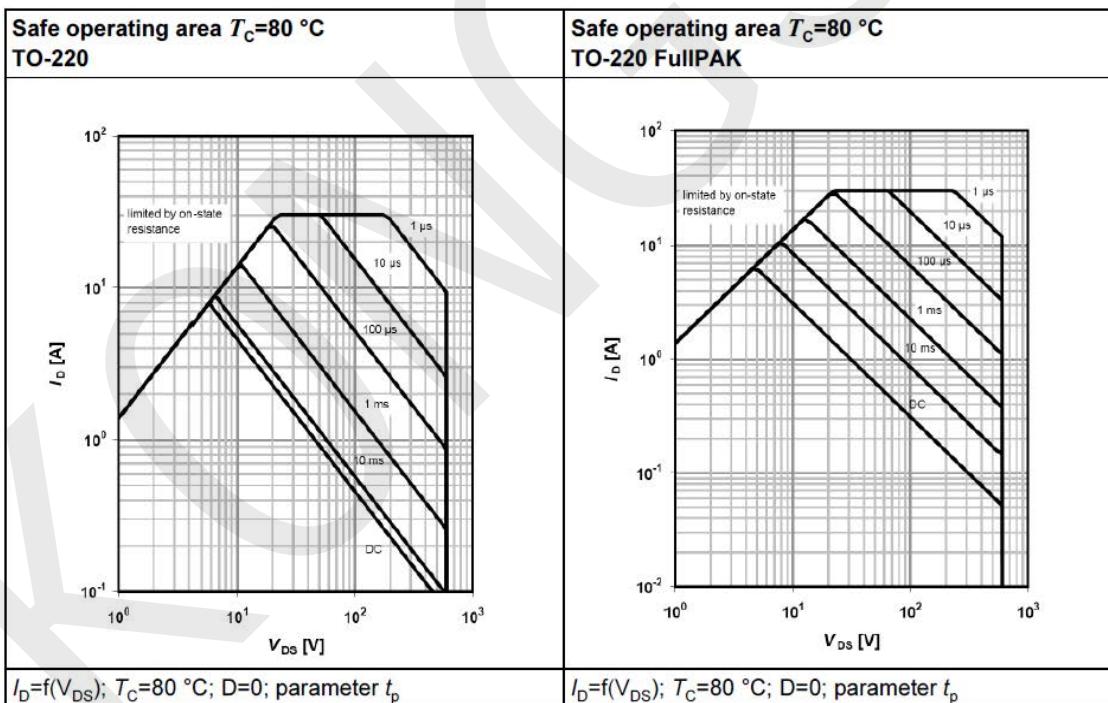
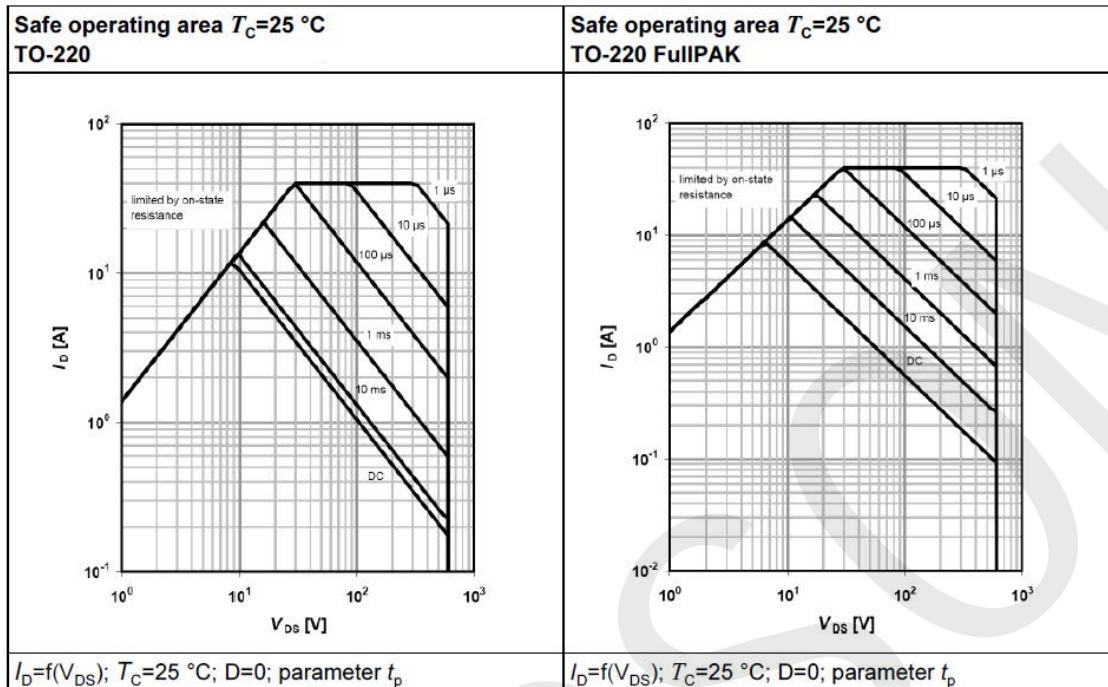
NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. I_{AS}=2.4A, V_{DD}=50V, Starting T_J=25 °C
3. I_{SD}≤I_D, di/dt ≤ 200A/us, V_{DD} ≤ BV_{DSS}, Starting T_J = 25 °C
4. Essentially Independent of Operating Temperature Typical Characteristics

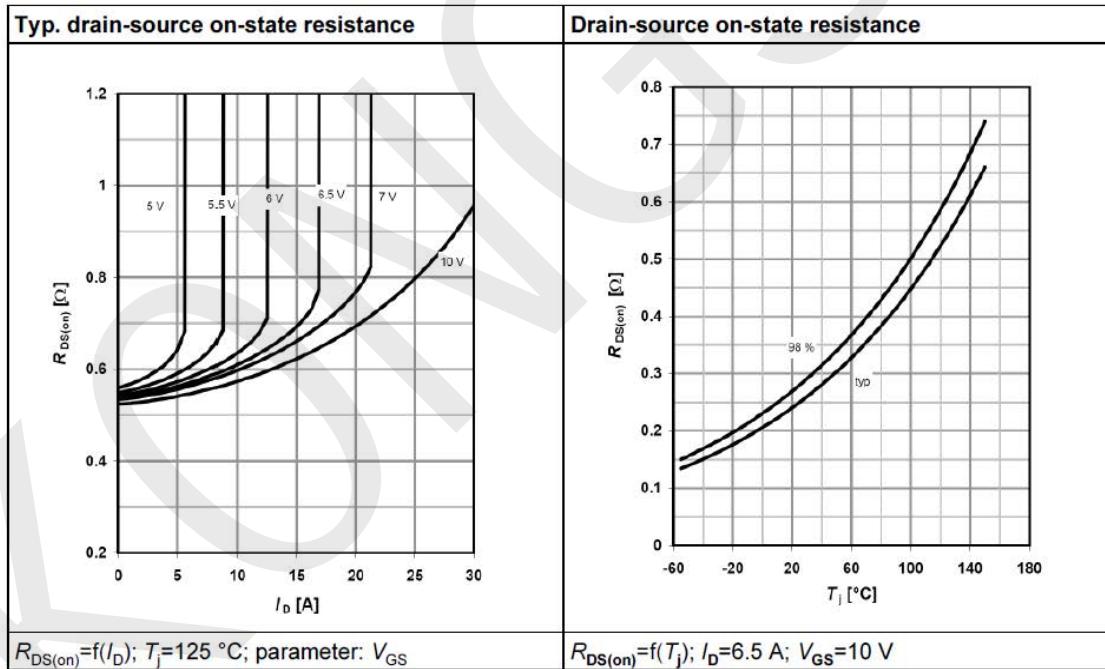
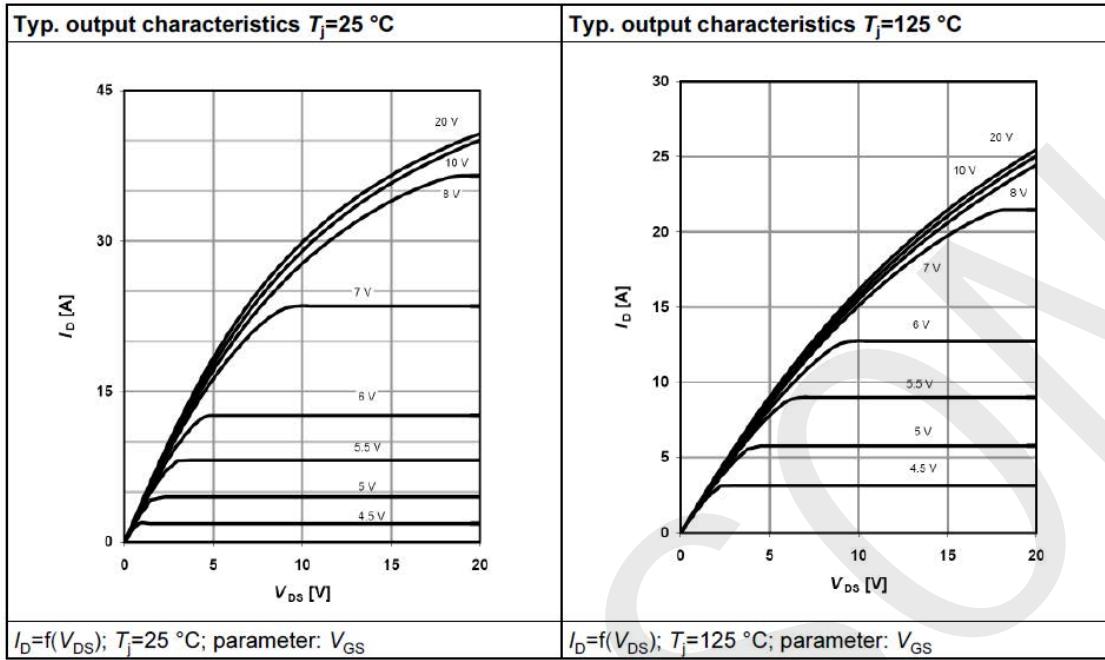
Typical Characteristics



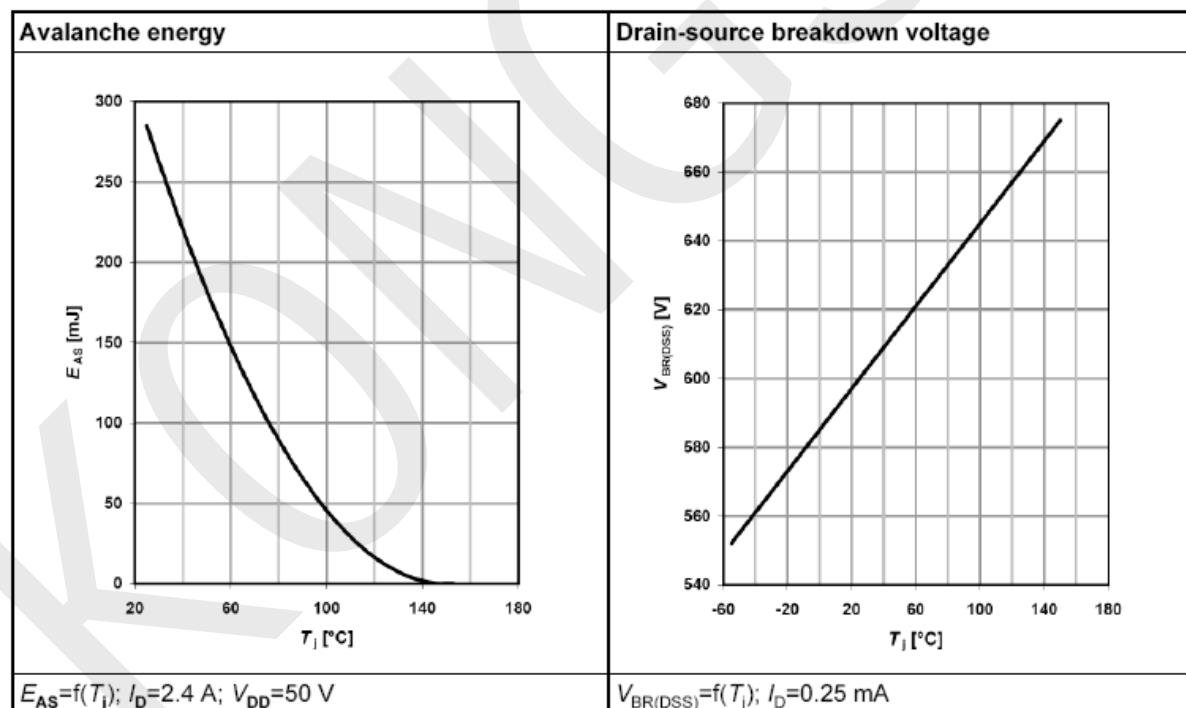
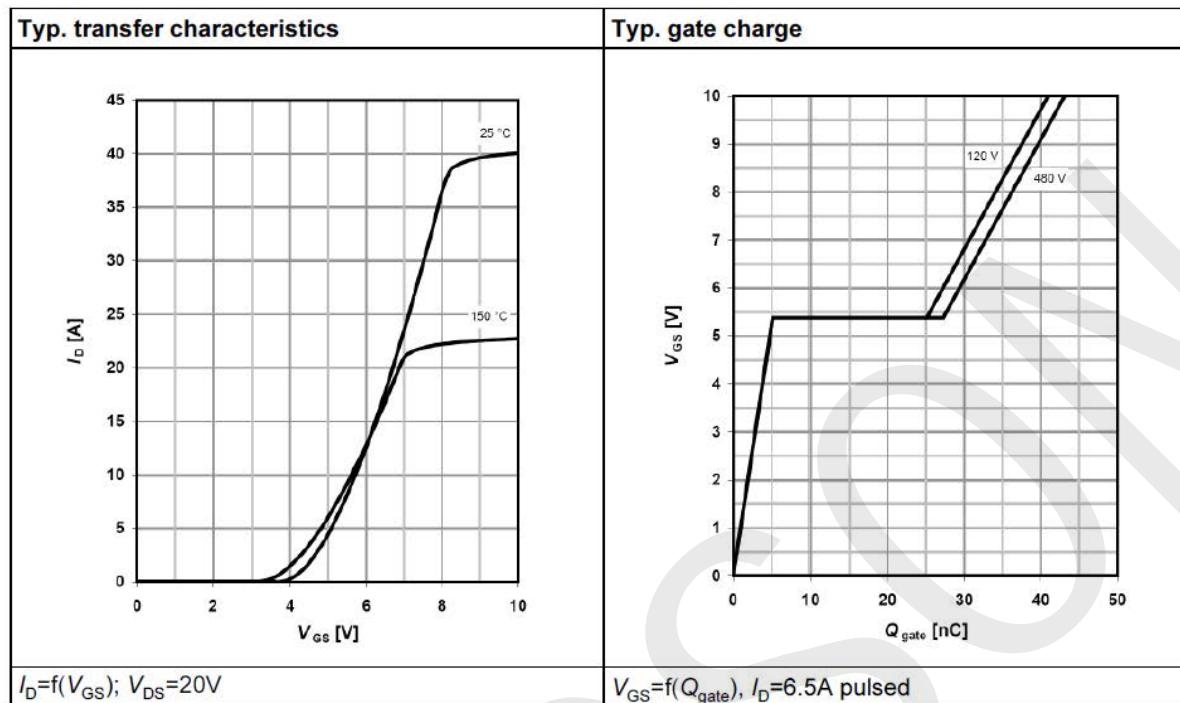
Typical Characteristics



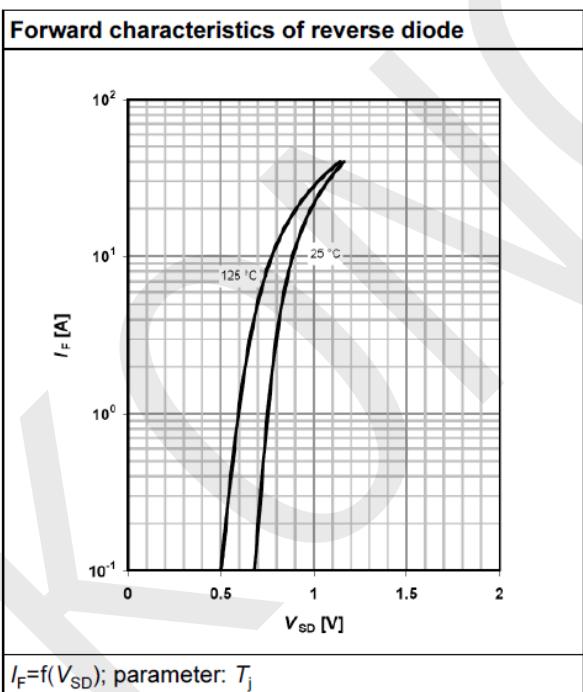
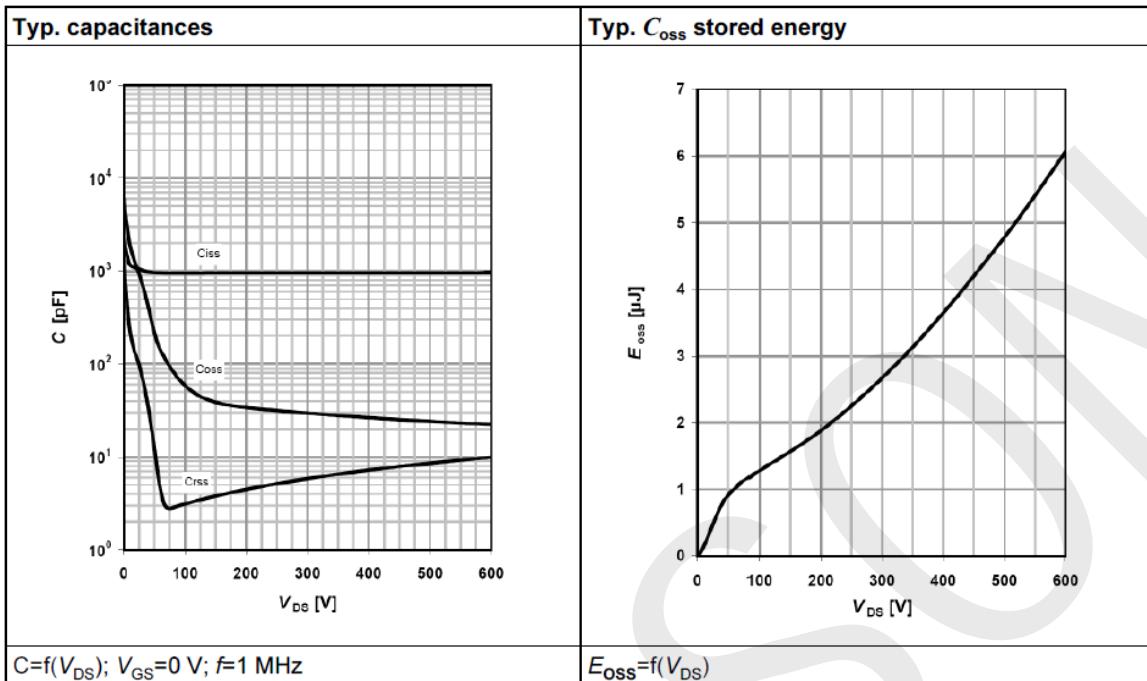
Typical Characteristics



Typical Characteristics



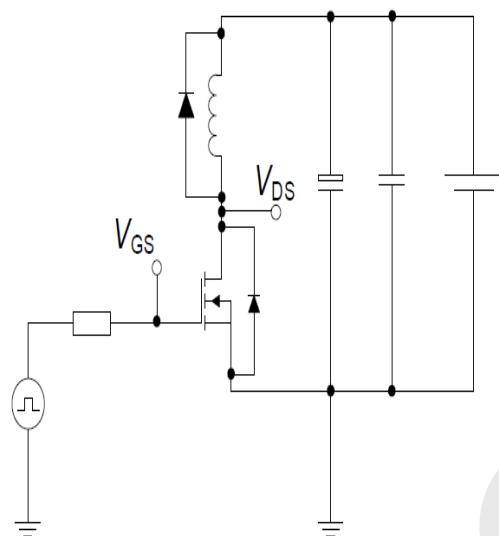
Typical Characteristics



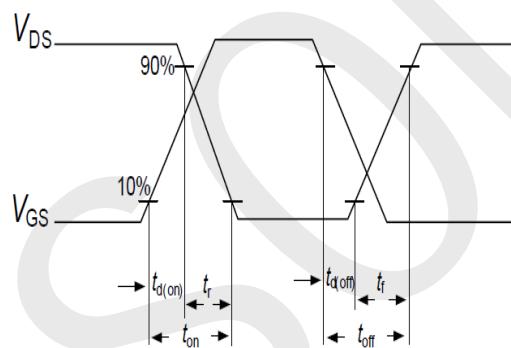
Test circuits

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

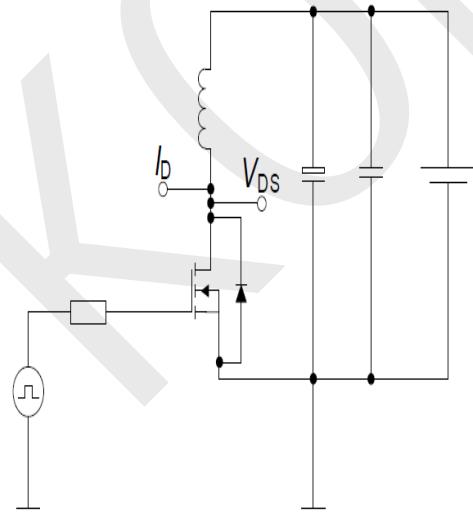


Switching time waveform

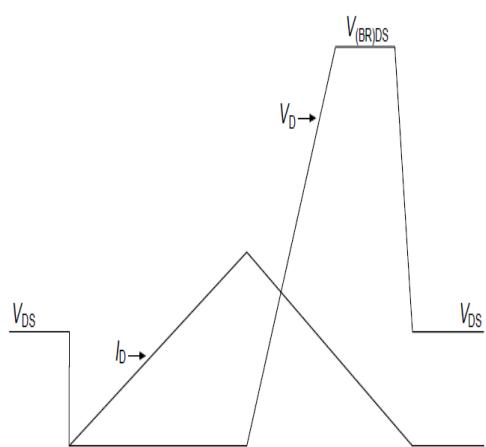


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit



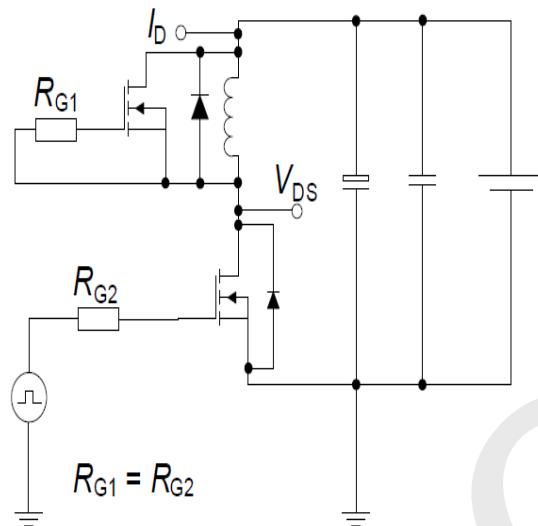
Unclamped inductive waveform



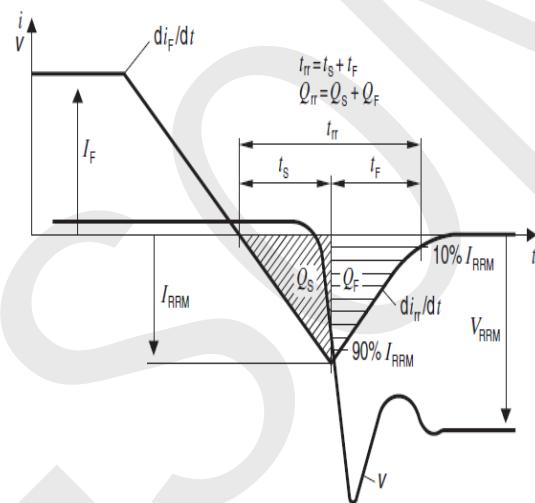
Test circuits

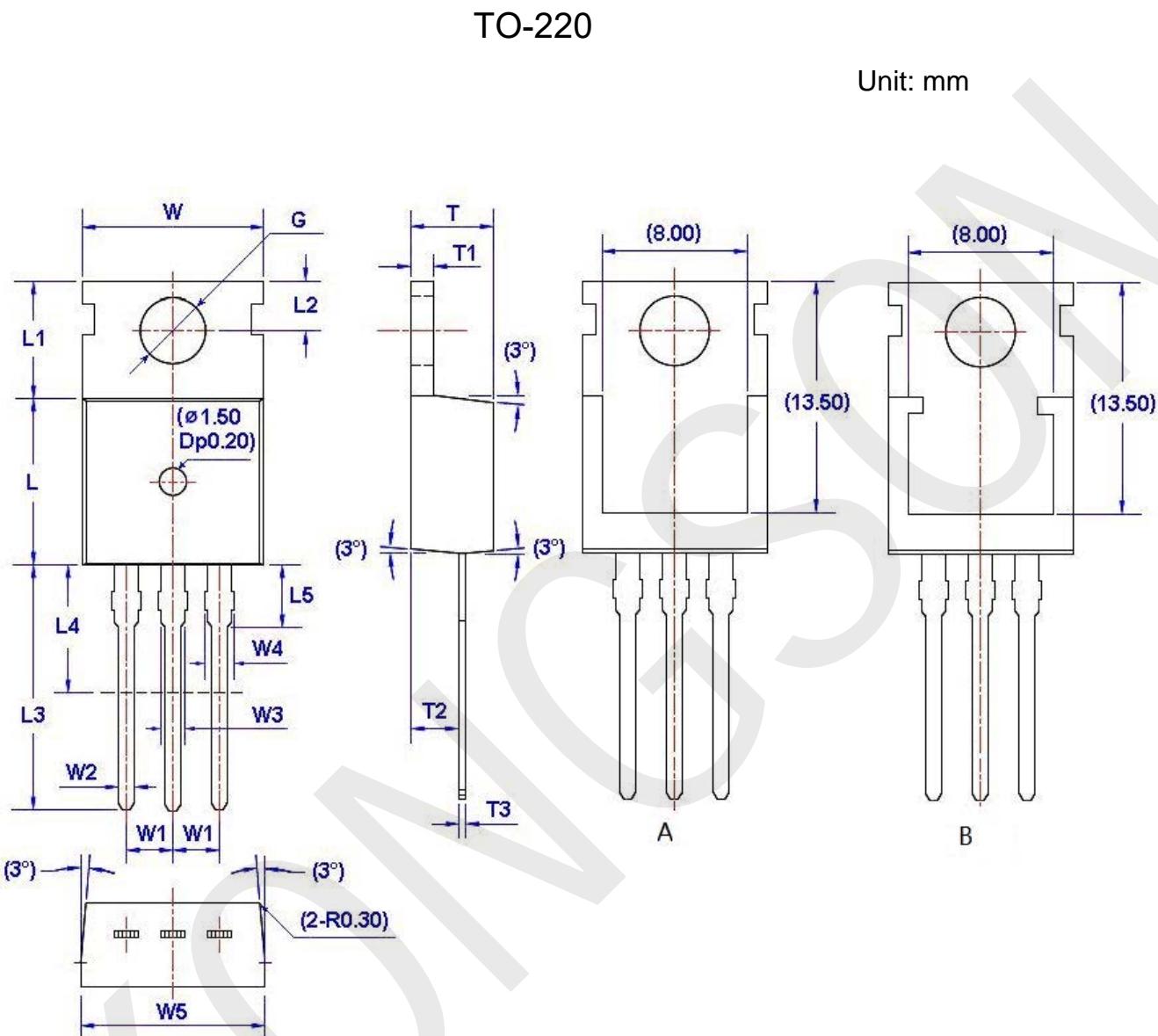
Test circuit and waveform for diode characteristics

Test circuit for diode characteristics



Diode recovery waveform



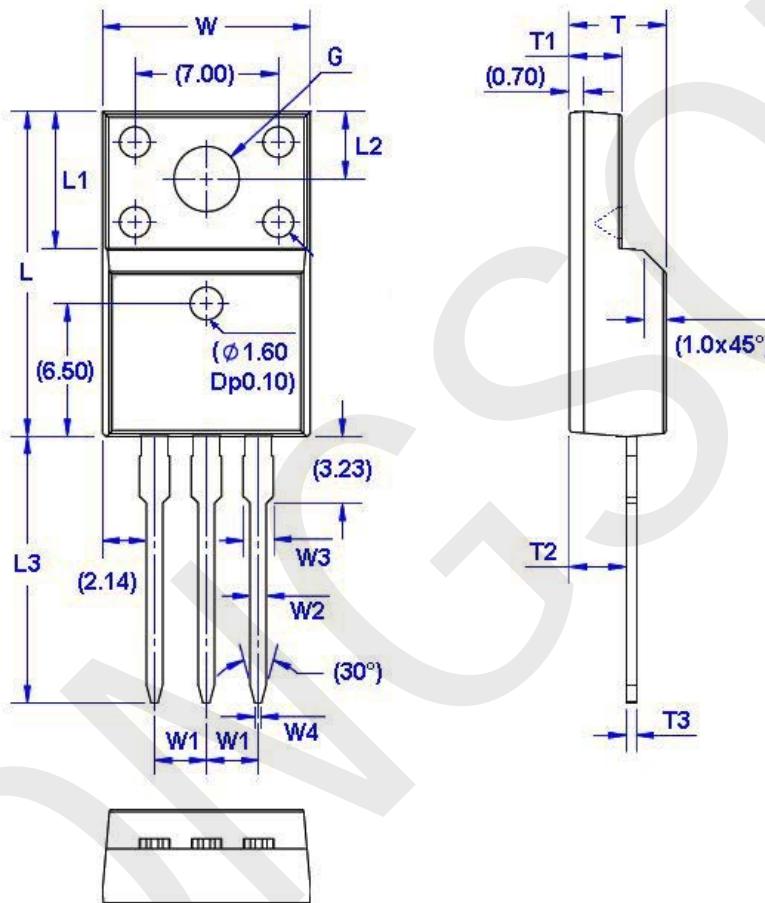
Package Dimension

Symbol	Size		Symbol	Size		Symbol	Size		Symbol	Size	
	Min	Max		Min	Max		Min	Max		Min	Max
W	9.66	10.28	W5	9.80	10.20	L4**	6.20	6.60	T3	0.45	0.60
W1	2.54 (TYP)		L	9.00	9.40	L5	2.79	3.30	G(Φ)	3.50	3.70
W2	0.70	0.95	L1	6.40	6.80	T	4.30	4.70			
W3	1.17	1.37	L2	2.70	2.90	T1	1.15	1.40			
W4*	1.32	1.72	L3	12.70	14.27	T2	2.20	2.60			

Package Dimension

TO-220F

Unit: mm



Symbol	Size		Symbol	Size		Symbol	Size		Symbol	Size	
	Min	Max		Min	Max		Min	Max		Min	Max
W	9.96	10.36	W4	0.25	0.45	L3	12.78	13.18	T3	0.45	0.60
W1	2.54 (TYP)		L	15.67	16.07	T	4.50	4.90	G(Φ)	3.08	3.28
W2	0.70	0.90	L1	6.48	6.88	T1	2.34	2.74			
W3	1.24	1.47	L2	3.20	3.40	T2	2.56	2.96			